

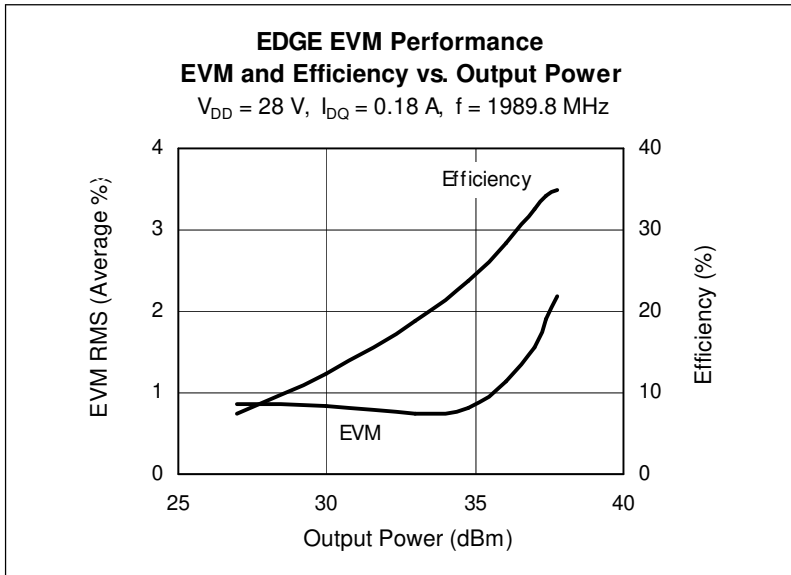
# LDMOS RF Power Field Effect Transistor

## 10 W, 1805–1880 MHz, 1930–1990 MHz

## 10 W, 2110–2170 MHz

### Description

The PTF180101 is a 10 W, internally-matched *GOLDMOS* FET device intended for EDGE applications in the DCS/PCS band. Full gold metallization ensures excellent device lifetime and reliability.



### Features

- Typical EDGE performance
  - Average output power = 4.0 W
  - Gain = 19.0 dB
  - Efficiency = 28%
  - EVM = 1.1 %
- Typical WCDMA performance
  - Average output power = 1.8 W
  - Gain = 18.0 dB
  - Efficiency = 20%
  - ACPR = -45 dBc
- Typical CW performance
  - Output power at P-1dB = 15 W
  - Efficiency = 50%
- Integrated ESD protection: Human Body Model Class 1 (minimum)
- Excellent thermal stability
- Low HCI drift
- Capable of handling 10:1 VSWR @ 28 V, 10 W (CW) output power

PTF180101S  
Package 32259



**ESD:** Electrostatic discharge sensitive device — observe handling precautions!

### RF Characteristics, EDGE Operation at $T_{CASE} = 25^{\circ}C$ unless otherwise indicated

**EDGE Measurements** (not subject to production test—verified by design/characterization in Infineon test fixture)

$V_{DD} = 28 V$ ,  $I_{DQ} = 180 mA$ ,  $P_{OUT} = 4 W$ ,  $f = 1989.8 MHz$

Characteristic	Symbol	Min	Typ	Max	Units
Error Vector Magnitude	EVM (RMS)	—	1.1	—	%
Modulation Spectrum @ 400 kHz	ACPR	—	-60	—	dBc
Modulation Spectrum @ 600 kHz	ACPR	—	-70	—	dBc
Gain	$G_{ps}$	—	19	—	dB
Drain Efficiency	$\eta_D$	—	28	—	%

**Two-Tone Measurements** (tested in Infineon test fixture)

$V_{DD} = 28 V$ ,  $I_{DQ} = 180 mA$ ,  $P_{OUT} = 10 W$  PEP,  $f = 1990 MHz$ , tone spacing = 1 MHz

Characteristic	Symbol	Min	Typ	Max	Units
Gain	$G_{ps}$	18	19	—	dB
Drain Efficiency	$\eta_D$	30	33	—	%
Intermodulation Distortion	IMD	—	-30	-28	dBc

**RF Characteristics, WCDMA Operation** at  $T_{CASE} = 25^{\circ}C$  unless otherwise indicated

**WCDMA Measurements** (not subject to production test—verified by design/characterization in Infineon test fixture)

 $V_{DD} = 28\text{ V}$ ,  $I_{DQ} = 135\text{ mA}$ ,  $P_{OUT} = 1.8\text{ W}$ ,

 $f = 2170\text{ MHz}$ , 3GPP signal, channel bandwidth = 3.84 MHz, peak/average = 8.7 dB @ 0.01% CCDF

Characteristic	Symbol	Min	Typ	Max	Units
Adjacent Channel Power Ratio	ACPR	—	-45	—	dBc
Gain	$G_{ps}$	—	18	—	dB
Drain Efficiency	$\eta_D$	—	20	—	%

**Two-Tone Measurements** (not subject to production test—verified by design/characterization in Infineon test fixture)

 $V_{DD} = 28\text{ V}$ ,  $I_{DQ} = 135\text{ mA}$ ,  $P_{OUT} = 10\text{ W PEP}$ ,  $f = 2170\text{ MHz}$ , tone spacing = 1 MHz

Characteristic	Symbol	Min	Typ	Max	Units
Gain	$G_{ps}$	—	18	—	dB
Drain Efficiency @ -30 dBc IM3	$\eta_D$	—	37	—	%
Intermodulation Distortion	IMD	—	-30	—	dBc

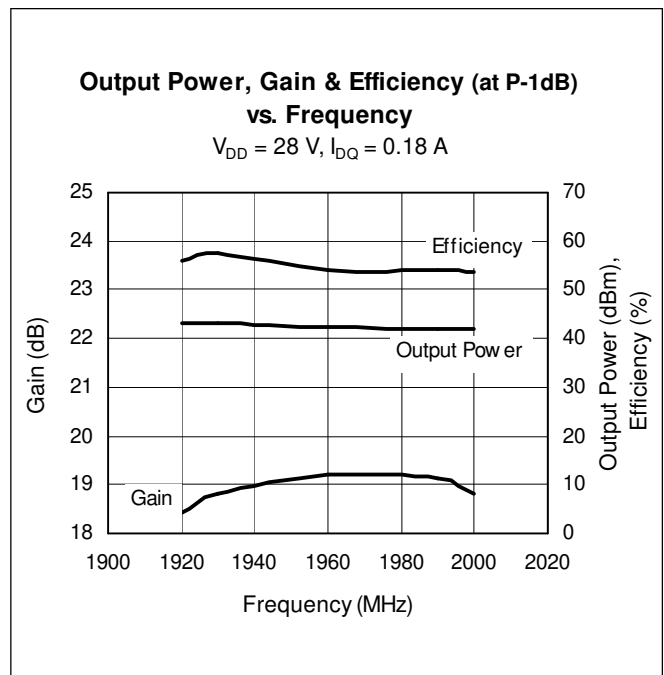
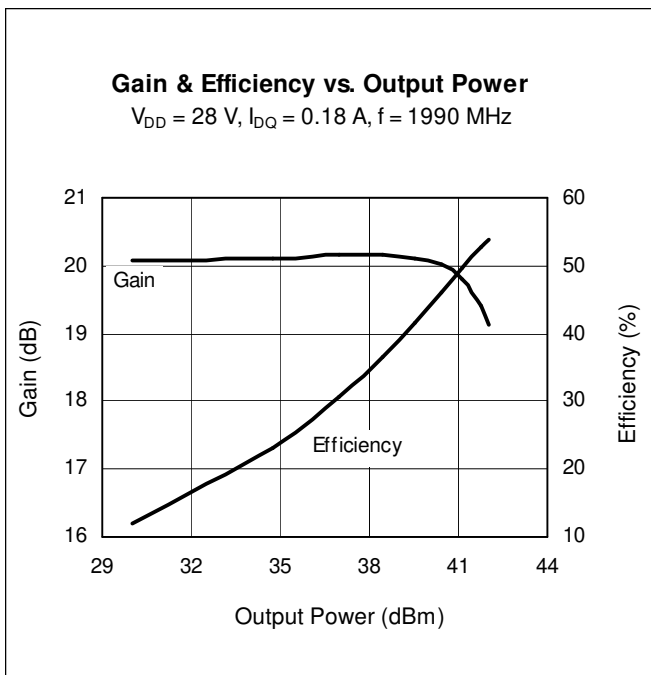
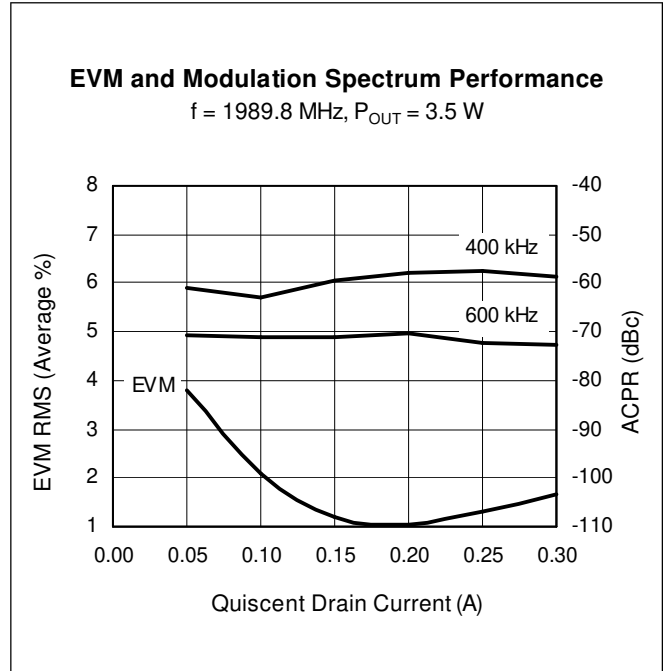
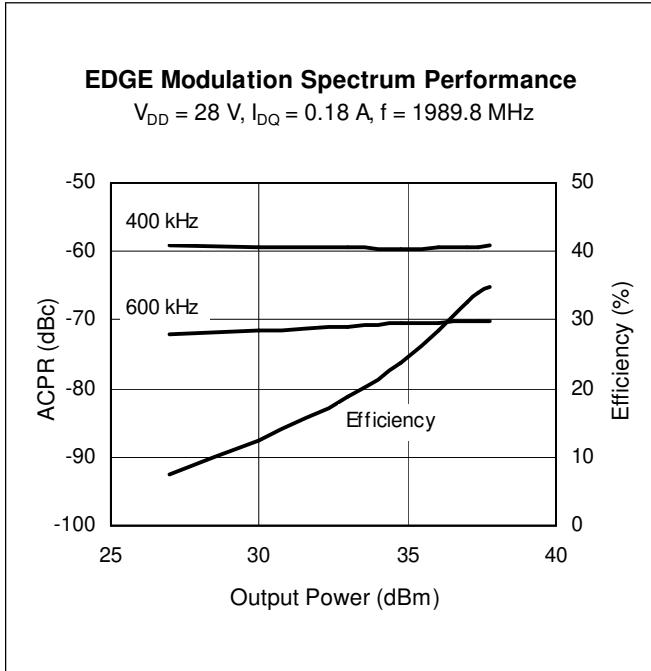
**DC Characteristics** at  $T_{CASE} = 25^{\circ}C$  unless otherwise indicated

Characteristic	Conditions	Symbol	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}$ , $I_{DS} = 10\text{ }\mu\text{A}$	$V_{(BR)DSS}$	65	—	—	V
Drain Leakage Current	$V_{DS} = 28\text{ V}$ , $V_{GS} = 0\text{ V}$	$I_{DSS}$	—	—	1.0	$\mu\text{A}$
On-State Resistance	$V_{GS} = 10\text{ V}$ , $V_{DS} = 0.1\text{ A}$	$R_{DS(on)}$	—	0.83	—	$\Omega$
Operating Gate Voltage	$V_{DS} = 28\text{ V}$ , $I_{DQ} = 180\text{ mA}$	$V_{GS}$	2.5	3.2	4.0	V
Gate Leakage Current	$V_{GS} = 10\text{ V}$ , $V_{DS} = 0\text{ V}$	$I_{GSS}$	—	—	1.0	$\mu\text{A}$

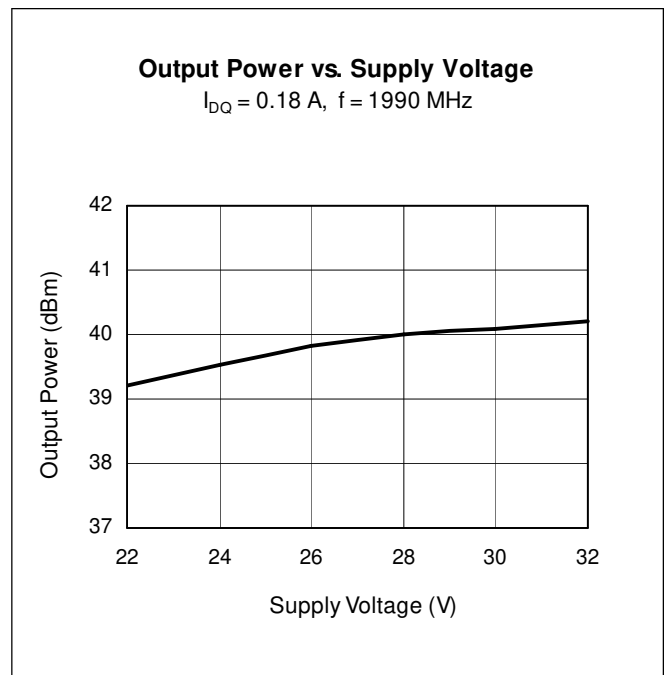
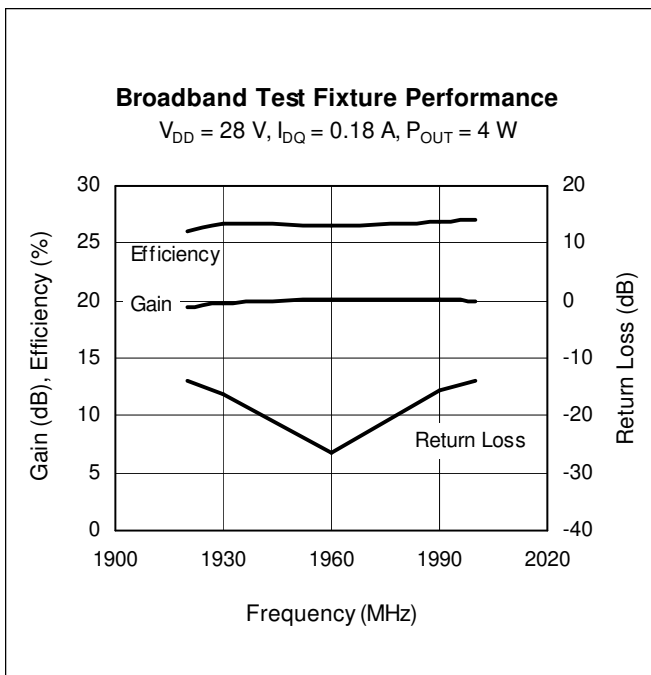
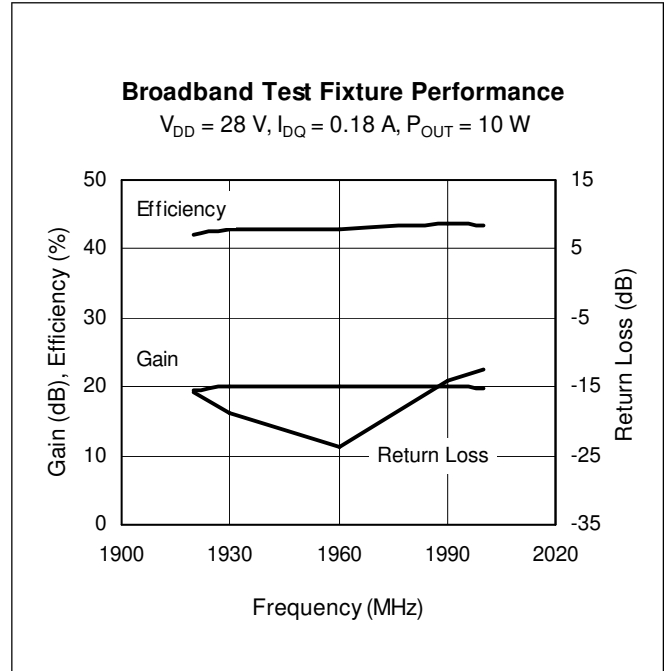
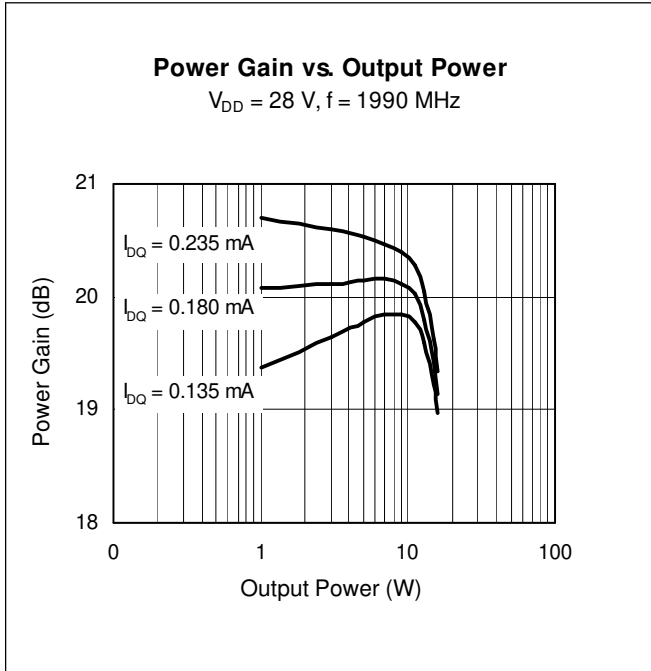
**Maximum Ratings** at  $T_{CASE} = 25^{\circ}C$  unless otherwise indicated

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	65	V
Gate-Source Voltage	$V_{GS}$	-0.5 to +12	V
Junction Temperature	$T_J$	200	$^{\circ}C$
Total Device Dissipation	$P_D$	58	W
Above 25 $^{\circ}C$ derate by		0.333	W/ $^{\circ}C$
Storage Temperature Range	$T_{STG}$	-40 to +150	$^{\circ}C$
Thermal Resistance ( $T_{CASE} = 70^{\circ}C$ , 10 W CW)	$R_{\theta JC}$	3.0	$^{\circ}C/W$

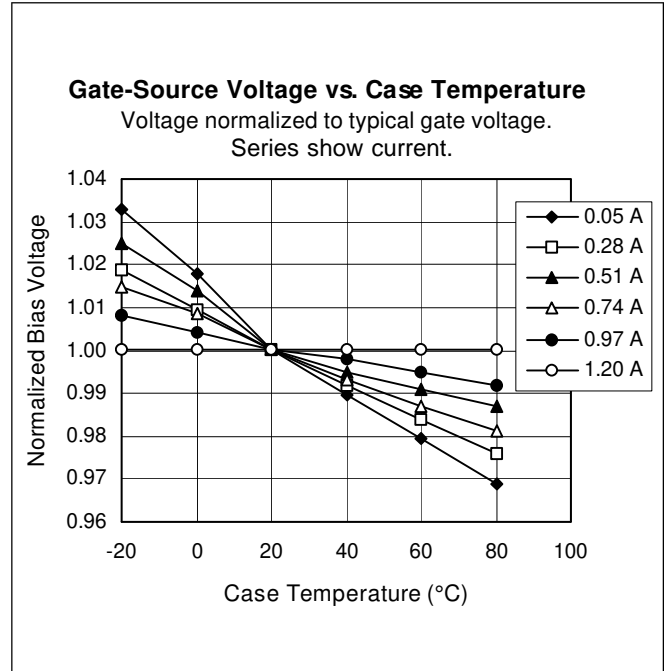
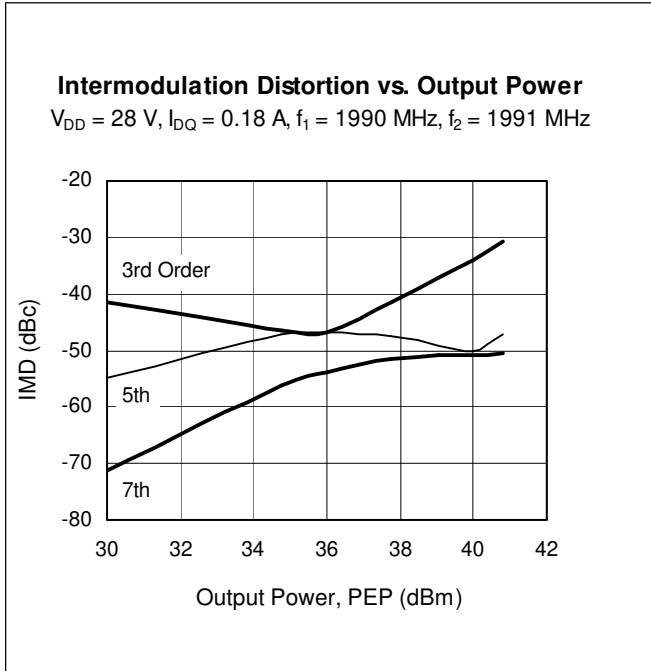
**Typical Performance** measurements taken in broadband test fixture



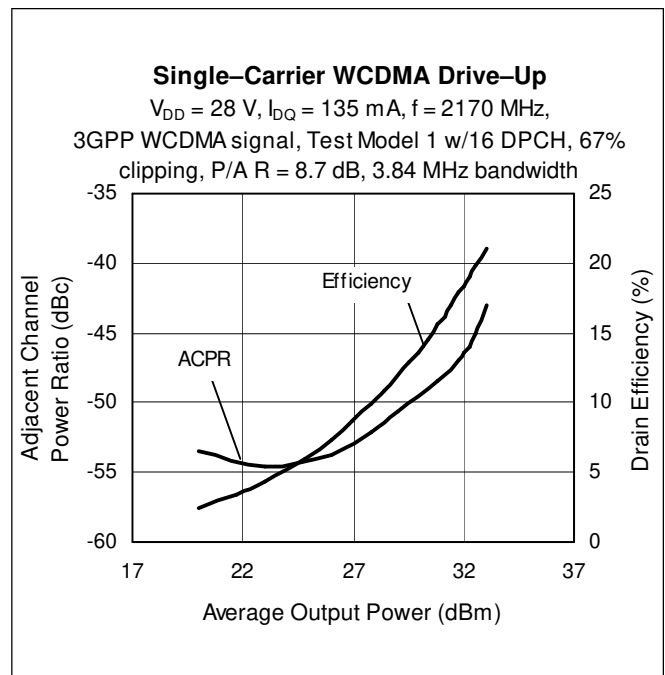
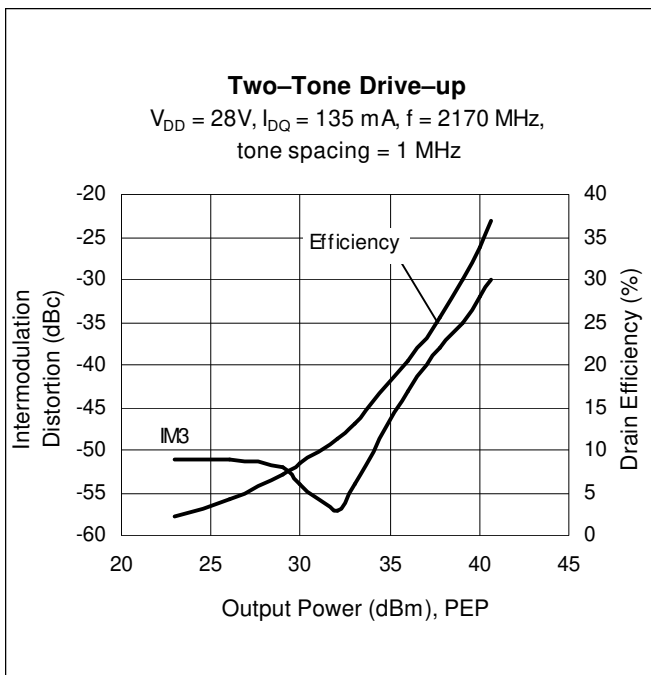
Typical Performance (cont.)



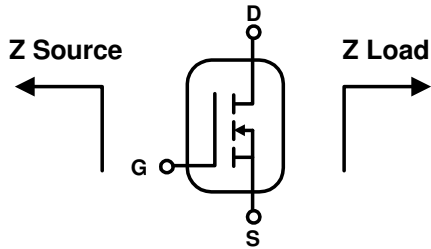
Typical Performance (cont.)



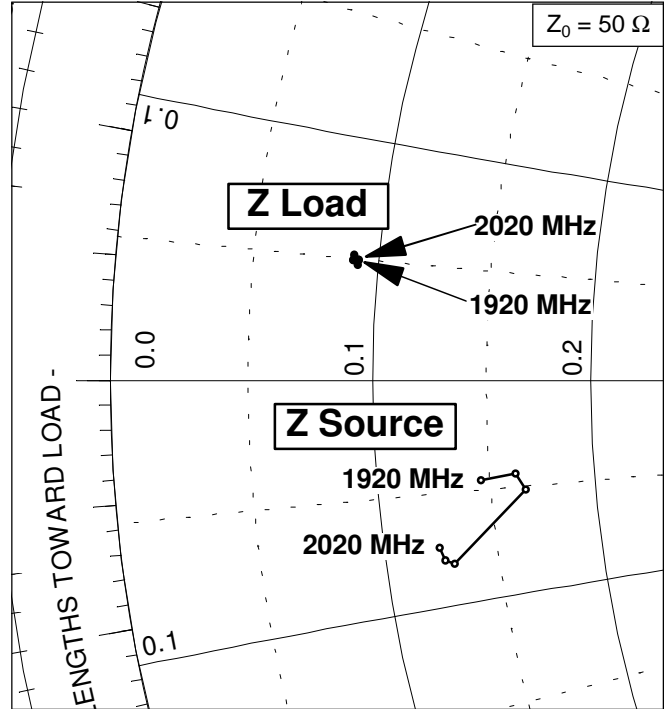
Typical Performance, WCDMA Operation



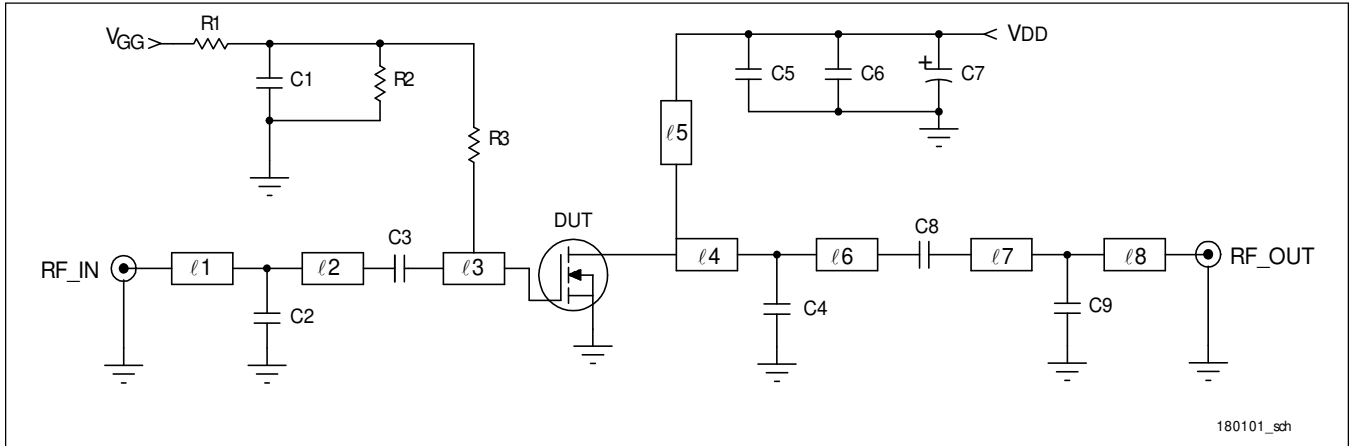
**Broadband Circuit Impedance Data**



Frequency MHz	Z Source $\Omega$		Z Load $\Omega$	
	R	jX	R	jX
1920	7.3	-2.3	4.6	2.4
1930	8.1	-2.2	4.6	2.5
1960	8.3	-2.6	4.5	2.6
1990	6.5	-4.1	4.5	2.5
2000	6.3	-4.0	4.5	2.5
2020	6.2	-3.7	4.6	2.5



### Reference Circuits



Reference Circuit Schematic

#### Circuit Assembly Information

DUT	PTF180101	LDMOS Transistor	
Circuit Board	0.76 mm [.030"] thick, $\epsilon_r = 4.5$	Rogers TMM4, 2 oz. Copper	

Microstrip	Electrical Characteristics at 1990 MHz	Dimensions: L x W (mm)	Dimensions: L x W (in.)
$\ell 1$	$0.133 \lambda$ , $50 \Omega$	10.92 x 1.37	0.430 x 0.054
$\ell 2$	$0.096 \lambda$ , $50 \Omega$	7.87 x 1.37	0.310 x 0.054
$\ell 3$	$0.155 \lambda$ , $9.5 \Omega$	11.30 x 12.45	0.445 x 0.490
$\ell 4$	$0.008 \lambda$ , $12.8 \Omega$	0.64 x 8.86	0.025 x 0.349
$\ell 5$	$0.286 \lambda$ , $70 \Omega$	23.88 x 0.71	0.940 x 0.028
$\ell 6$	$0.247 \lambda$ , $12.8 \Omega$	18.29 x 8.86	0.720 x 0.349
$\ell 7$	$0.145 \lambda$ , $50 \Omega$	11.81 x 1.37	0.465 x 0.054
$\ell 8$	$0.008 \lambda$ , $50 \Omega$	0.64 x 1.37	0.025 x 0.054

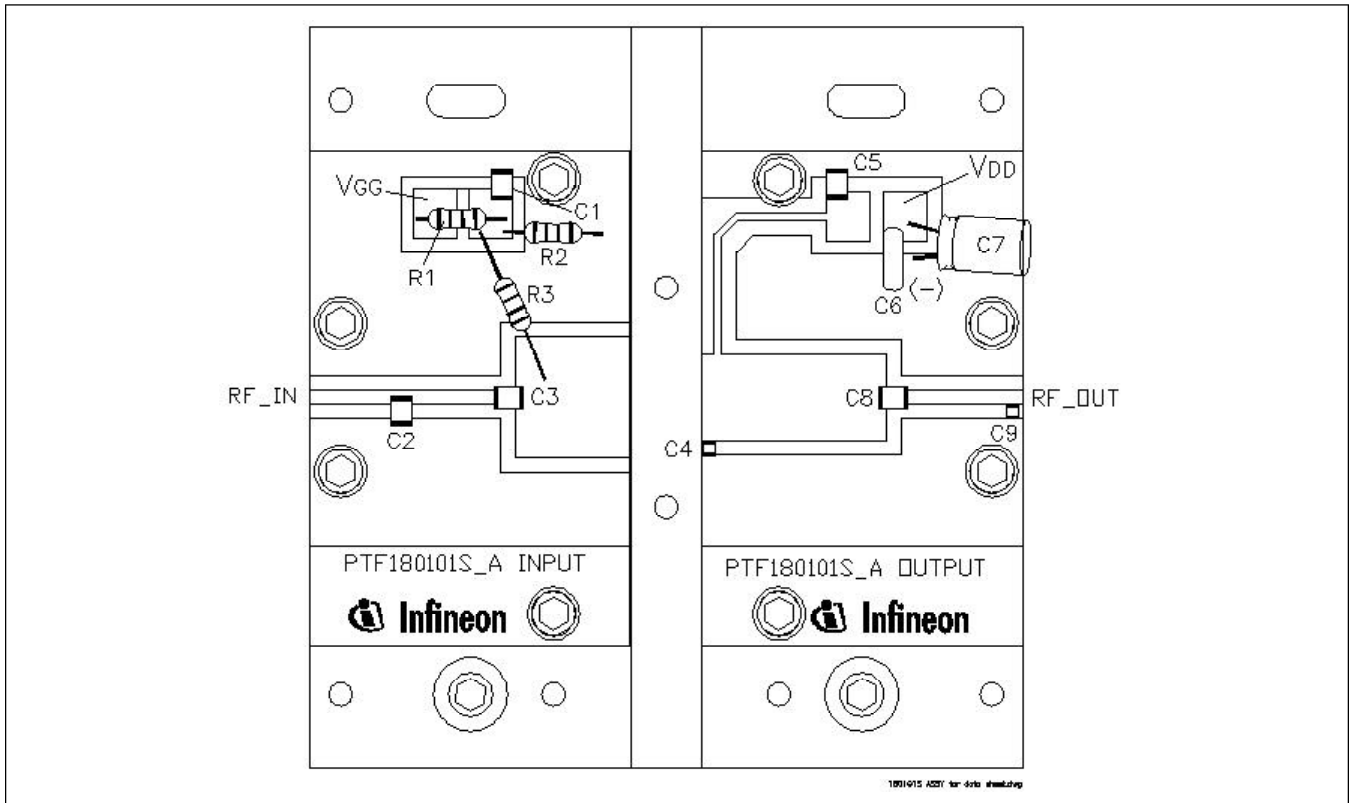
**Reference Circuits** (cont.)

1930–1990 MHz Operation

Component	Description	Manufacturer	P/N or Comment
C1, C3, C5, C8	Capacitor, 10 pF	ATC	100B 100
C2	Capacitor, 1.7 pF	ATC	100B 1R7
C4	Capacitor, 2.0 pF	ATC	100A 2R0
C6	Capacitor, 0.1 $\mu$ F, 50 V	Digi-Key	P4525-ND
C7	Capacitor, 100 $\mu$ F, 50 V	Digi-Key	P5182-ND
C9	Capacitor, 0.6 pF	ATC	100A 0R6
R1, R2, R3	Resistor, 220 ohm, 1/4 W	Digi-Key	220QBK

2.11–2.17 GHz Operation

Component	Description	Manufacturer	P/N or Comment
C1, C3, C5, C8	Capacitor, 10 pF	ATC	100B 100
C2	Capacitor, 0.8 pF	ATC	100B 0R8
C4	Capacitor, 2.2 pF	ATC	100A 2R2
C6	Capacitor, 0.1 $\mu$ F, 50 V	Digi-Key	P4525-ND
C7	Capacitor, 100 $\mu$ F, 50 V	Digi-Key	P5182-ND
C9	Capacitor, 1.0 pF	ATC	100A 1R0
R1, R2, R3	Resistor, 220 ohm, 1/4 W	Digi-Key	220QBK



Reference circuit assembly diagram<sup>1</sup> (not to scale)

<sup>1</sup> Gerber files for this circuit are available upon request.





Previous Version: none

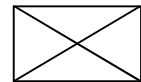
Page	Subjects (major changes since last revision)
1, 5, 7	Add information about WCDMA operation

**We Listen to Your Comments**

Any information within this document that you feel is wrong, unclear or missing at all?  
 Your feedback will help us to continuously improve the quality of this document.  
 Please send your proposal (including a reference to this document) to:

[highpowerRF@infineon.com](mailto:highpowerRF@infineon.com)

To request other information, contact us at:  
 +1 877 465 3667 (1-877-GOLDMOS) USA  
 or +1 408 776 0600 International

**Edition 2004-02-03**

**Published by Infineon Technologies AG,  
 St.-Martin-Strasse 53,  
 81669 München, Germany**

**© Infineon Technologies AG 2003.  
 All Rights Reserved.**

**Attention please!**

The information herein is given to describe certain components and shall not be considered as a guarantee of characteristics.  
 Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

**Information**

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office ([www.infineon.com/rfpower](http://www.infineon.com/rfpower)).

**Warnings**

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.